



60V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on) max}	I _D T _C = +25°C
-60V	$110m\Omega @ V_{GS} = -10V$	-14A
-000	140mΩ @ V_{GS} = -4.5V	-12A

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions
- Analog Switch

Features and Benefits

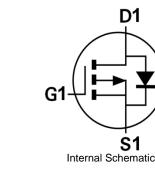
- Low On-Resistance
- Low Input Capacitance
- Totally Lead-Free & Fully RoHS compliant (Note 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: TO252 (DPAK)
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.33 grams (approximate)



Top View



Ordering Information (Note 4)

Compliance	Case	Packaging
Standard	TO252	2,500/Tape & Reel
	Standard	Standard TO252

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Top View

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1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

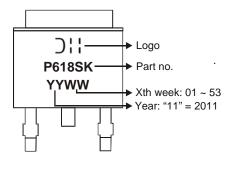
2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

Notes:





Maximum Ratings ($@T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage			VDSS	-60	V
Gate-Source Voltage			V _{GSS}	±20	V
Continuous Drain Current (Note 6) V _{GS} = -10V	Steady State	T _C = +25°C T _C = +100°C	ID	-14 -10	A
Maximum Body Diode Forward Current (Note 6)			Is	4.1	А
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I _{DM}	25	А

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Total Power Dissipation (Note 5)	T _A = +25°C	D-	1.7	W	
Total Power Dissipation (Note 5)	T _A = +70°C	PD	1.0		
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	P	76	°C/W	
Thermal Resistance, sunction to Ambient (Note 5)	t<10s	$R_{ extsf{ heta}JA}$	33		
Total Power Dissipation (Note 6)	T _A = +25°C	D _	2.7	W	
Total Fower Dissipation (Note 0)	T _A = +70°C	PD	1.5		
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	P	50	°C/W	
Thermal Resistance, Subction to Ambient (Note 0)	t<10s	$R_{ extsf{ heta}JA}$	24		
Total Power Dissipation (Note 6)	$T_{\rm C} = +25^{\circ}{\rm C}$	Pn	40	W	
Total Fower Dissipation (Note 0)	T _C = +100°C	FD	16	vv	
Thermal Resistance, Junction to Case (Note 6)	Steady state	R _θ JC	3.1	°C/W	
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C	

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Tun	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)	Symbol	WIIN	Тур	Wax	Unit	Test Condition	
		-60			V	V 0V 1 250: A	
Drain-Source Breakdown Voltage	BV _{DSS}					$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	IDSS		_	-1	μA	$V_{DS} = -48V, V_{GS} = 0V$	
Gate-Source Leakage	IGSS	_	—	100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)				1	i	1	
Gate Threshold Voltage	V _{GS(th)}	-1.2	—	-2.7	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance	Proven	_	60	110	mΩ	$V_{GS} = -10V, I_D = -12A$	
Static Drain-Source On-Resistance	R _{DS (ON)}	_	80	140	11122	$V_{GS} = -4.5V, I_D = -8A$	
Forward Transfer Admittance	Y _{fs}	_	15	_	S	V _{DS} = -5V, I _D = -12A	
Diode Forward Voltage	V _{SD}	_	-0.7	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss	_	984.7			$V_{DS} = -30V, V_{GS} = 0V, f = 1.0MHz$	
Output Capacitance	C _{oss}	_	58		pF		
Reverse Transfer Capacitance	Crss		45.5				
Gate Resistance	R _G	_	12.9	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V _{GS} = -4.5V)	Qg	_	8.1	_			
Total Gate Charge (V _{GS} = -10V)	Qg	_	17.1	_	nC	$V_{DS} = -30V, I_D = -12A$	
Gate-Source Charge	Q _{gs}	_	3.2		10		
Gate-Drain Charge	Q _{gd}	_	3.9	_			
Turn-On Delay Time	t _{D(on)}	_	5.9			$V_{GS} = -10V, V_{DS} = -30V, R_{GEN} = 3\Omega, \label{eq:generalized_generalized_states}$ $R_L = 2.5\Omega$	
Turn-On Rise Time	tr	_	21.2				
Turn-Off Delay Time	t _{D(off)}	_	30.9		ns		
Turn-Off Fall Time	t _f		39.1		1		
Body Diode Reverse Recovery Time	t _{rr}		19.9		ns	I _S = -12A, dl/dt = 100A/µs	
Body Diode Reverse Recovery Charge	Q _{rr}		1.7		nC	I _S = -12A, dl/dt = 100A/µs	

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

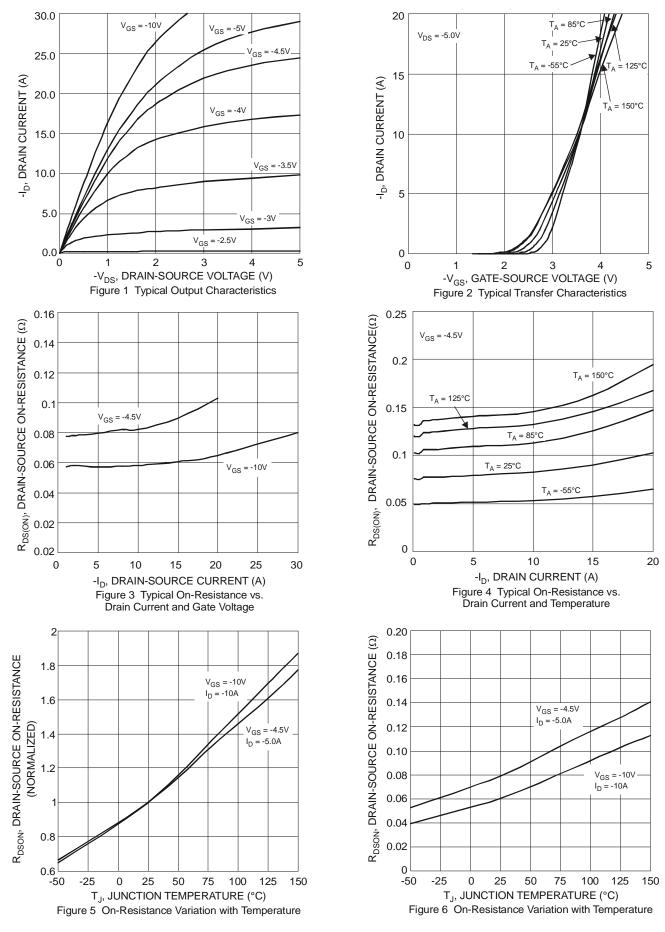
6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper pad layout.

7. Short duration pulse test used to minimize self-heating effect

8. Guaranteed by design. Not subject to production testing

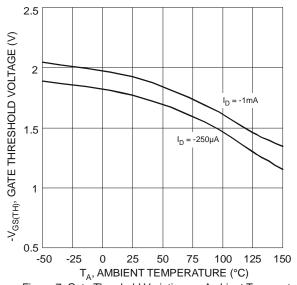


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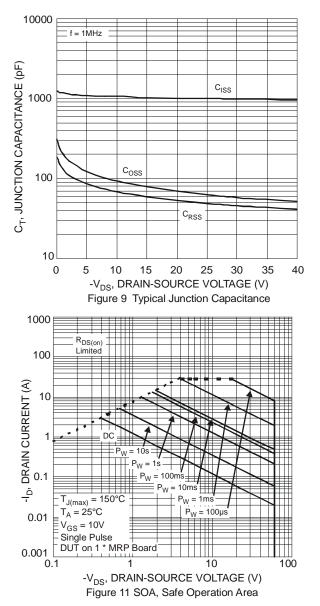


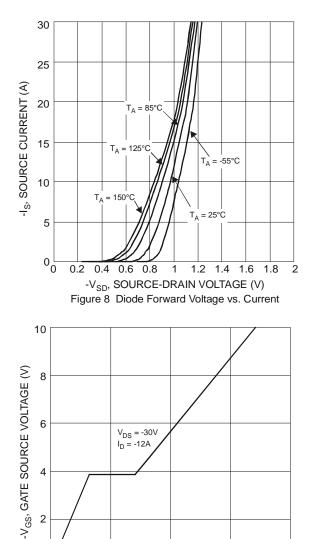
DMP6180SK3 Document number: DS36172 Rev. 3 - 2 Downloaded from Arrow.com.











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Q_G, TOTAL GATE CHARGE (nC)

Figure 10 Gate Charge Characteristics

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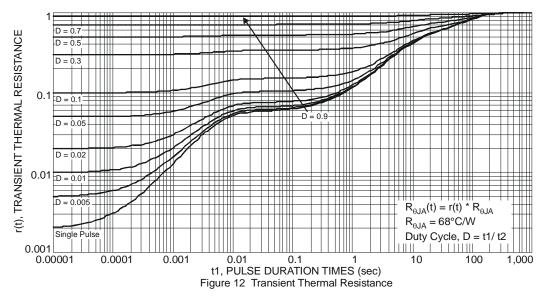
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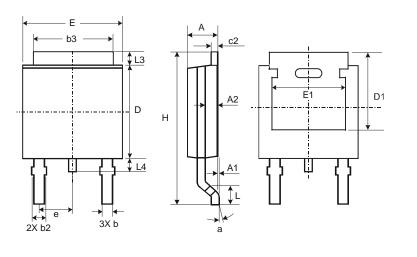
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Package Outline Dimensions

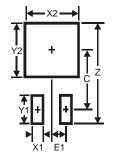
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



TO252					
Dim Min Max Typ					
Α	2.19	2.39	2.29		
A1	0.00	0.13	0.08		
A2	0.97	1.17	1.07		
b	0.64	0.88	0.783		
b2	0.76	1.14	0.95		
b3	5.21	5.46	5.33		
c2	0.45	0.58	0.531		
D	6.00	6.20	6.10		
D1	5.21	-	-		
е	-	-	2.286		
Е	6.45	6.70	6.58		
E1	4.32	-	-		
Н	9.40	10.41	9.91		
L	1.40	1.78	1.59		
L3	0.88	1.27	1.08		
L4	0.64	1.02	0.83		
а	0°	10°	_		
All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)			
Z	11.6			
X1	1.5			
X2	7.0			
Y1	2.5			
Y2	7.0			
С	6.9			
E1	2.3			



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